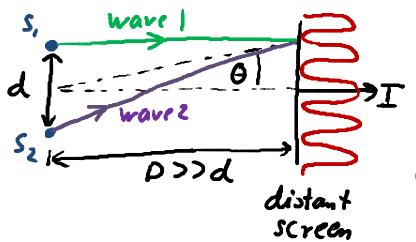
· Interference:

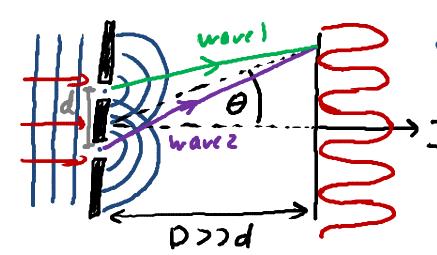
- for two waves from two sources or for double slit:



• path lensth difference for the two wars:

o Maxima (constructive inta feeq)

at: | d sin θ = m λ | m = 0, ± 1, ± 2...



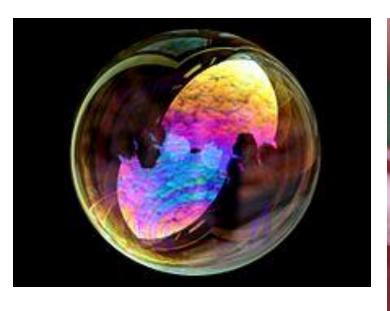
· Minima (destractive intefera)

ati dsin
$$\theta = \left(m + \frac{1}{2}\right) \lambda m = 0, \pm 1, \pm 2...$$

· Very marrow slits (width < λ) behave like a point source.

Today:

- Thin-film Interference
- Diffraction
 - Single slit

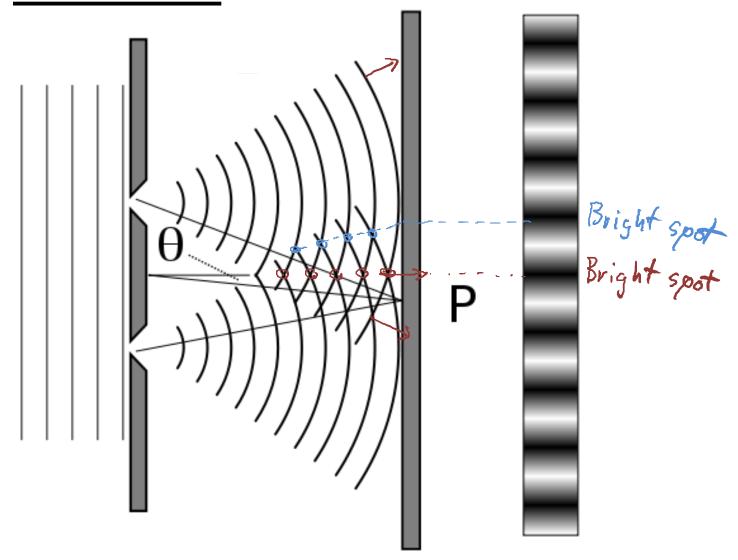








Interference between waves from two narrow slits

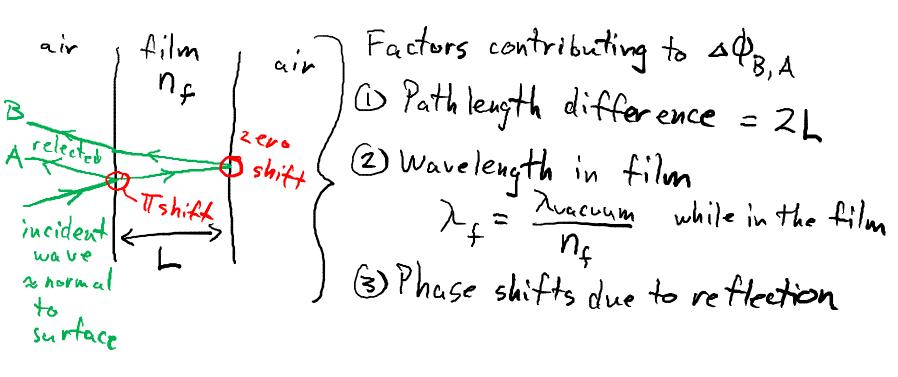


Sources phase difference between two waves (1) (Last time) path length difference $\Delta \phi = \frac{2\pi}{\lambda}$ spath (2) Waves travel at different speeds through different mediums (characterized by index of refraction, n) Example: wave $\#1 - through vacuum c = \lambda_1 f \Rightarrow \lambda_1 = \frac{c}{f}$ wave#2 - through some material Vwave = $\frac{c}{n} = \lambda_2 f \Rightarrow \lambda_2 = \frac{c}{nf} = \lambda / n$ λ2<λ, because n>1 #1 This is prelative pricture phase shift a destructive interence

(3) Phase shift due to refle	ction from some interface
· Mechanical analogy	
Before interface	
heavy string light string	
no phase { change { Vuave, fast Vuave, slow	180° phase shift Vw, slow 'Vw fast
· E-M waves	
Reflection type	Phase shift in reflection
slow -> fast	
Nincident > Ntransmitted	
fast -> slaw	\prod
Nincident < Ntransmitted)

Thin-Film Interference

· Consider a thin film of thickness L in air



Total phase shift between B and A:
$$\Delta \Phi_{B,A} = \Phi_B - \Phi_A = \left(\frac{2\pi}{\lambda_f} 2L + 0\right) - \pi = \frac{2\pi}{\lambda_{vac}} n_f(2L) - \pi$$

=> Constructive intereference condition

$$\Delta \phi_{B,A} = m(2\pi) \Rightarrow 2L_m = (m + \frac{1}{2}) \frac{\lambda_{vacuum}}{n_f} \quad m = 0,1,2...$$

$$\Rightarrow \text{ Destructive interfence condition}$$

$$\Delta \Phi_{B,A} = \left[\text{integer} + \frac{1}{2} \right] (2\pi) \Rightarrow 2L = m \frac{\lambda \text{ vacuum }}{N f} \quad m = 0,1,2...$$

Note what happens with extremely thin film 2>>L = always have destructive interfence of reflection

Examples of Thin-Film Interference

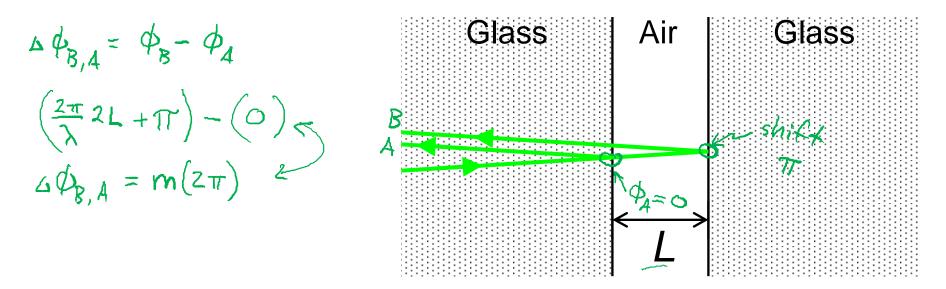
Soap bubble



Thin oil film



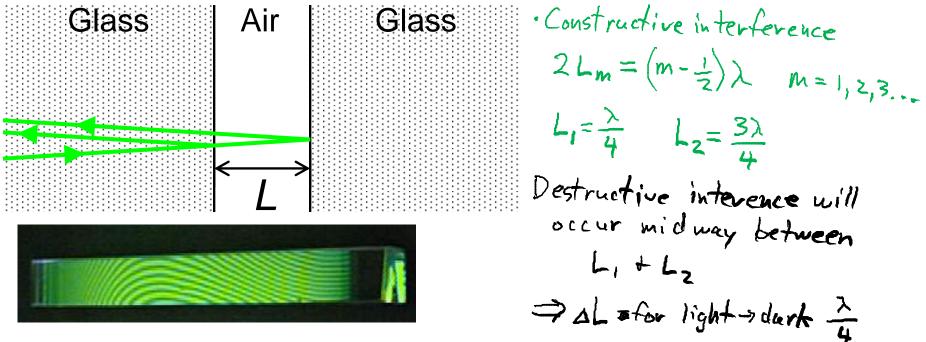
Example: Thin film of air:



For a given (vacuum) wavelength λ of normally incident light, which equation gives the film thicknesses for constructive interference of reflected light?

A.
$$2L_m = m\lambda$$
, $m = 0, 1, 2, ...$
B. $2L_m = (m - \frac{1}{2})\lambda$, $m = 1, 2, ...$
C. Neither of the above equations.

Example: Thin film of air:



For (vacuum) wavelength $\lambda = 550$ nm of normally incident light, what is the film thickness difference between the center of a dark fringe and the center of one of its adjacent bright fringes?

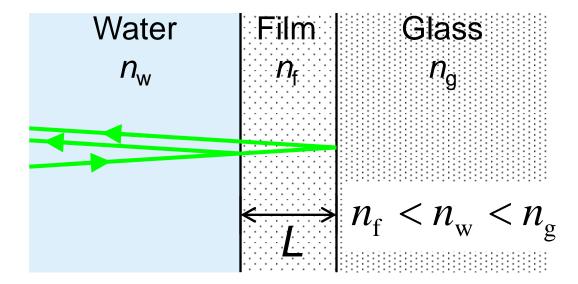
A. 1100 nm B. 550 nm C. 275 nm D. 183 nm E 138 nm

Example: Antireflection coating:

For a given (vacuum) wavelength λ of normally incident light, which equation gives the film thicknesses for destructive interference of reflected light?

A.
$$2L_m = m\lambda/n_f$$
, $m = 0, 1, 2, ...$
B. $2L_m = (m + \frac{1}{2}) \lambda/n_f$, $m = 1, 2, ...$
C. Neither of the above equations.

Example: Antireflection coating:



For a given (vacuum) wavelength λ of normally incident visible light, the thin film has the minimum thickness required for it to function as an antireflection coating when the coated glass is in air.

If the coated glass is immersed in water, will the thin film function as an antireflection coating for any <u>visible</u> light?

A. Yes.

B. No.

C. Not enough information.